

## Preliminary datasheet

### EasyPACK™ module with CoolSiC™ Trench MOSFET and PressFIT / NTC

#### Features

- Electrical features
  - $V_{DSS} = 1200 \text{ V}$
  - $I_{DN} = 50 \text{ A} / I_{DRM} = 100 \text{ A}$
  - Low inductive design
  - High current density
- Mechanical features
  - Integrated NTC temperature sensor
  - PressFIT contact technology
  - Rugged mounting due to integrated mounting clamps



Typical appearance

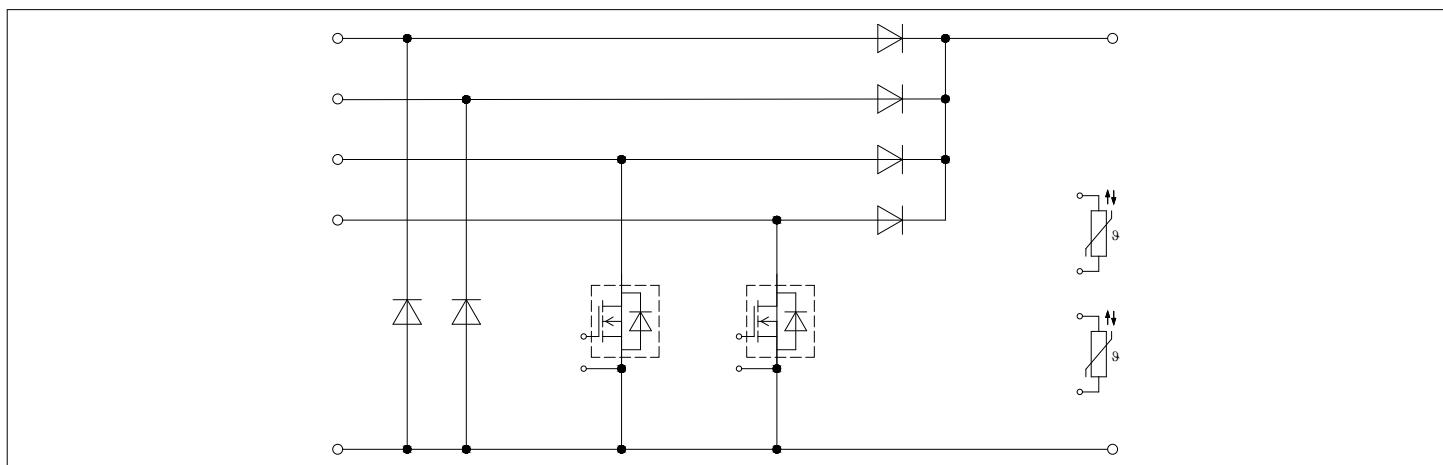
#### Potential applications

- Solar applications

#### Product validation

- Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

#### Description



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## 1 Package

**Table 1 Insulation coordination**

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	$V_{ISOL}$	RMS, $f = 50 \text{ Hz}$ , $t = 1 \text{ min}$	3.0	kV
Internal isolation		basic insulation (class 1, IEC 61140)	$\text{Al}_2\text{O}_3$	
Comparative tracking index	$CTI$		> 200	
Relative thermal index (electrical)	$RTI$	housing	140	°C

**Table 2 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Stray inductance module	$L_{sCE}$			10		nH
Module lead resistance, terminals - chip	$R_{AA'+CC'}$	$T_H = 25 \text{ °C}$ , per switch		3		mΩ
Module lead resistance, terminals - chip	$R_{CC'+EE'}$	$T_H = 25 \text{ °C}$ , per switch		2		mΩ
Storage temperature	$T_{stg}$		-40		125	°C
Mounting force per clamp	$F$		20		50	N
Weight	$G$			24		g

*Note:* The current under continuous operation is limited to 25 A rms per connector pin.

## 2 MOSFET

**Table 3 Maximum rated values**

Parameter	Symbol	Note or test condition		Values	Unit
Drain-source voltage	$V_{DSS}$		$T_{vj} = 25 \text{ °C}$	1200	V
Implemented drain current	$I_{DN}$			50	A
Continuous DC drain current	$I_{DDC}$	$T_{vj} = 175 \text{ °C}$ , $V_{GS} = 18 \text{ V}$	$T_H = 65 \text{ °C}$	45	A
Repetitive peak drain current	$I_{DRM}$	verified by design, $t_p$ limited by $T_{vjmax}$		100	A
Gate-source voltage, max. transient voltage	$V_{GS}$	$D < 0.01$		-10/23	V
Gate-source voltage, max. static voltage	$V_{GS}$			-7/20	V

**Table 4 Recommended values**

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	$V_{GS(on)}$		15...18	V
Off-state gate voltage	$V_{GS(off)}$		-5...0	V

**Table 5 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Drain-source on-resistance	$R_{DS(on)}$	$I_D = 50 \text{ A}$	$V_{GS} = 18 \text{ V}, T_{vj} = 25^\circ\text{C}$		16.2	mΩ
			$V_{GS} = 18 \text{ V}, T_{vj} = 125^\circ\text{C}$		26.1	
			$V_{GS} = 18 \text{ V}, T_{vj} = 175^\circ\text{C}$		34.7	
			$V_{GS} = 15 \text{ V}, T_{vj} = 25^\circ\text{C}$		19.4	
Gate threshold voltage	$V_{GS(th)}$	$I_D = 20 \text{ mA}, V_{DS} = V_{GS}, T_{vj} = 25^\circ\text{C}$ , (tested after 1ms pulse at $V_{GS} = +20 \text{ V}$ )	3.45	4.3	5.15	V
Total gate charge	$Q_G$	$V_{DD} = 800 \text{ V}, V_{GS} = -3/18 \text{ V}$		0.149		μC
Internal gate resistor	$R_{Gint}$	$T_{vj} = 25^\circ\text{C}$		4.1		Ω
Input capacitance	$C_{ISS}$	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V}, T_{vj} = 25^\circ\text{C}$ $V_{GS} = 0 \text{ V}$		4.4		nF
Output capacitance	$C_{OSS}$	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V}, T_{vj} = 25^\circ\text{C}$ $V_{GS} = 0 \text{ V}$		0.21		nF
Reverse transfer capacitance	$C_{rss}$	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V}, T_{vj} = 25^\circ\text{C}$ $V_{GS} = 0 \text{ V}$		0.014		nF
$C_{OSS}$ stored energy	$E_{OSS}$	$V_{DS} = 800 \text{ V}, V_{GS} = -3/18 \text{ V}, T_{vj} = 25^\circ\text{C}$		86		μJ
Drain-source leakage current	$I_{DSS}$	$V_{DS} = 1200 \text{ V}, V_{GS} = -3 \text{ V}$	$T_{vj} = 25^\circ\text{C}$	0.03	210	μA
Gate-source leakage current	$I_{GSS}$	$V_{DS} = 0 \text{ V}, T_{vj} = 25^\circ\text{C}$	$V_{GS} = 20 \text{ V}$		400	nA
Turn-on delay time (inductive load)	$t_{d(on)}$	$I_D = 50 \text{ A}, R_{Gon} = 3.3 \Omega, V_{DD} = 600 \text{ V}, V_{GS} = -3/18 \text{ V}$	$T_{vj} = 25^\circ\text{C}$		32	ns
			$T_{vj} = 125^\circ\text{C}$		32	
			$T_{vj} = 175^\circ\text{C}$		32	
Rise time (inductive load)	$t_r$	$I_D = 50 \text{ A}, R_{Gon} = 3.3 \Omega, V_{DD} = 600 \text{ V}, V_{GS} = -3/18 \text{ V}$	$T_{vj} = 25^\circ\text{C}$		23.9	ns
			$T_{vj} = 125^\circ\text{C}$		23.9	
			$T_{vj} = 175^\circ\text{C}$		23.9	

(table continues...)

**Table 5 (continued) Characteristic values**

<b>Parameter</b>	<b>Symbol</b>	<b>Note or test condition</b>	<b>Values</b>			<b>Unit</b>
			<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	
Turn-off delay time (inductive load)	$t_{d\ off}$	$I_D = 50\ A, R_{Goff} = 2\ \Omega, V_{DD} = 600\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$		60.7	ns
			$T_{vj} = 125\ ^\circ C$		60.7	
			$T_{vj} = 175\ ^\circ C$		60.7	
Fall time (inductive load)	$t_f$	$I_D = 50\ A, R_{Goff} = 2\ \Omega, V_{DD} = 600\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$		10.5	ns
			$T_{vj} = 125\ ^\circ C$		10.5	
			$T_{vj} = 175\ ^\circ C$		10.5	
Turn-on energy loss per pulse	$E_{on}$	$I_D = 50\ A, V_{DD} = 600\ V, L_\sigma = 35\ nH, V_{GS} = -3/18\ V, R_{Gon} = 3.3\ \Omega, di/dt = 4.29\ kA/\mu s (T_{vj} = 175\ ^\circ C)$	$T_{vj} = 25\ ^\circ C$		0.516	mJ
			$T_{vj} = 125\ ^\circ C$		0.516	
			$T_{vj} = 175\ ^\circ C$		0.516	
Turn-off energy loss per pulse	$E_{off}$	$I_D = 50\ A, V_{DD} = 600\ V, L_\sigma = 35\ nH, V_{GS} = -3/18\ V, R_{Goff} = 2\ \Omega, dv/dt = 45.7\ kV/\mu s (T_{vj} = 175\ ^\circ C)$	$T_{vj} = 25\ ^\circ C$		0.133	mJ
			$T_{vj} = 125\ ^\circ C$		0.133	
			$T_{vj} = 175\ ^\circ C$		0.133	
Thermal resistance, junction to heat sink	$R_{thJH}$	per MOSFET			1.1	K/W
Temperature under switching conditions	$T_{vj\ op}$		-40		175	°C

**Note:** The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2021-13 must be considered to ensure sound operation of the device over the planned lifetime.

$T_{vj,op} > 150\ ^\circ C$  is allowed for operation at overload conditions for MOSFET and body diode. For detailed specifications, please refer to AN 2021-13.

### 3 Body diode

**Table 6 Maximum rated values**

<b>Parameter</b>	<b>Symbol</b>	<b>Note or test condition</b>		<b>Values</b>		<b>Unit</b>
DC body diode forward current	$I_{SD}$	$T_{vj} = 175\ ^\circ C, V_{GS} = -3\ V$	$T_H = 65\ ^\circ C$	24		A

**Table 7 Characteristic values**

<b>Parameter</b>	<b>Symbol</b>	<b>Note or test condition</b>	<b>Values</b>			<b>Unit</b>
			<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	
Forward voltage	$V_{SD}$	$I_{SD} = 50\ A, V_{GS} = -3\ V$	$T_{vj} = 25\ ^\circ C$		4.2	V
			$T_{vj} = 125\ ^\circ C$		3.9	
			$T_{vj} = 175\ ^\circ C$		3.8	

## 4 Diode, Boost

**Table 8 Maximum rated values**

Parameter	Symbol	Note or test condition	Values		Unit
Repetitive peak reverse voltage	$V_{RRM}$		1200		V
Continuous DC forward current	$I_F$		40		A
Repetitive peak forward current	$I_{FRM}$	$t_P = 1 \text{ ms}$	80		A
$I^2t$ - value	$I^2t$	$t_P = 10 \text{ ms}, V_R = 0 \text{ V}$	$T_{vj} = 125 \text{ }^\circ\text{C}$	320	$\text{A}^2\text{s}$
			$T_{vj} = 150 \text{ }^\circ\text{C}$	295	

**Table 9 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	$V_F$	$I_F = 40 \text{ A}, V_{GE} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$	1.40	1.85	V
			$T_{vj} = 125 \text{ }^\circ\text{C}$	1.70		
			$T_{vj} = 150 \text{ }^\circ\text{C}$	1.85		
Peak reverse recovery current	$I_{RM}$	$V_{CC} = 600 \text{ V}, I_F = 40 \text{ A}, -di_F/dt = 3900 \text{ A}/\mu\text{s}$ $(T_{vj} = 150 \text{ }^\circ\text{C})$	$T_{vj} = 25 \text{ }^\circ\text{C}$	43		A
			$T_{vj} = 125 \text{ }^\circ\text{C}$	43		
			$T_{vj} = 150 \text{ }^\circ\text{C}$	43		
Recovered charge	$Q_r$	$V_{CC} = 600 \text{ V}, I_F = 40 \text{ A}, -di_F/dt = 3900 \text{ A}/\mu\text{s}$ $(T_{vj} = 150 \text{ }^\circ\text{C})$	$T_{vj} = 25 \text{ }^\circ\text{C}$	4.03		$\mu\text{C}$
			$T_{vj} = 125 \text{ }^\circ\text{C}$	4.03		
			$T_{vj} = 150 \text{ }^\circ\text{C}$	4.03		
Reverse recovery energy	$E_{rec}$	$V_{CC} = 600 \text{ V}, I_F = 40 \text{ A}, -di_F/dt = 3900 \text{ A}/\mu\text{s}$ $(T_{vj} = 150 \text{ }^\circ\text{C})$	$T_{vj} = 25 \text{ }^\circ\text{C}$	0.063		$\text{mJ}$
			$T_{vj} = 125 \text{ }^\circ\text{C}$	0.063		
			$T_{vj} = 150 \text{ }^\circ\text{C}$	0.063		
Thermal resistance, junction to heat sink	$R_{thJH}$	per diode		1.11		K/W
Temperature under switching conditions	$T_{vj op}$		-40		150	$^\circ\text{C}$

## 5 Bypass-diode

**Table 10 Maximum rated values**

Parameter	Symbol	Note or test condition	Values		Unit
Repetitive peak reverse voltage	$V_{RRM}$		1200		V

(table continues...)

**Table 10 (continued) Maximum rated values**

Parameter	Symbol	Note or test condition	Values		Unit
Maximum RMS forward current per chip	$I_{FRMSM}$	$T_H = 80^\circ\text{C}$	50		A
Maximum RMS current at rectifier output	$I_{RMSM}$	$T_H = 80^\circ\text{C}$	50		A
Surge forward current	$I_{FSM}$	$t_P = 10 \text{ ms}$	$T_{vj} = 25^\circ\text{C}$	450	A
			$T_{vj} = 150^\circ\text{C}$	360	
$I^2t$ - value	$I^2t$	$t_P = 10 \text{ ms}$	$T_{vj} = 25^\circ\text{C}$	1010	$\text{A}^2\text{s}$
			$T_{vj} = 150^\circ\text{C}$	648	

**Table 11 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	$V_F$	$I_F = 30 \text{ A}$		0.95		V
Reverse current	$I_r$	$T_{vj} = 150^\circ\text{C}$ , $V_R = 1200 \text{ V}$		0.1		mA
Thermal resistance, junction to heat sink	$R_{thJH}$	per diode		1.29		K/W
Temperature under switching conditions	$T_{vj, op}$		-40		150	°C

## 6 Inverse-polarity protection diode

**Table 12 Maximum rated values**

Parameter	Symbol	Note or test condition	Values		Unit
Repetitive peak reverse voltage	$V_{RRM}$		1200		V
Maximum RMS forward current per chip	$I_{FRMSM}$	$T_H = 80^\circ\text{C}$	50		A
Maximum RMS current at rectifier output	$I_{RMSM}$	$T_H = 80^\circ\text{C}$	50		A
Surge forward current	$I_{FSM}$	$t_P = 10 \text{ ms}$	$T_{vj} = 25^\circ\text{C}$	450	A
			$T_{vj} = 150^\circ\text{C}$	360	
$I^2t$ - value	$I^2t$	$t_P = 10 \text{ ms}$	$T_{vj} = 25^\circ\text{C}$	1010	$\text{A}^2\text{s}$
			$T_{vj} = 150^\circ\text{C}$	648	

**Table 13 Characteristic values**

<b>Parameter</b>	<b>Symbol</b>	<b>Note or test condition</b>	<b>Values</b>			<b>Unit</b>
			<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	
Forward voltage	$V_F$	$I_F = 30 \text{ A}$   $T_{vj} = 150 \text{ }^\circ\text{C}$		0.95		V
Reverse current	$I_r$	$T_{vj} = 150 \text{ }^\circ\text{C}$ , $V_R = 1200 \text{ V}$		0.1		mA
Thermal resistance, junction to heat sink	$R_{thJH}$	per diode		1.16		K/W
Temperature under switching conditions	$T_{vj, op}$		-40		150	$^\circ\text{C}$

## 7 NTC-Thermistor

**Table 14 Characteristic values**

<b>Parameter</b>	<b>Symbol</b>	<b>Note or test condition</b>	<b>Values</b>			<b>Unit</b>
			<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	
Rated resistance	$R_{25}$	$T_{NTC} = 25 \text{ }^\circ\text{C}$		5		k $\Omega$
Deviation of $R_{100}$	$\Delta R/R$	$T_{NTC} = 100 \text{ }^\circ\text{C}$ , $R_{100} = 493 \Omega$	-5		5	%
Power dissipation	$P_{25}$	$T_{NTC} = 25 \text{ }^\circ\text{C}$			20	mW
B-value	$B_{25/50}$	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298,15 \text{ K}))]$		3375		K
B-value	$B_{25/80}$	$R_2 = R_{25} \exp[B_{25/80}(1/T_2 - 1/(298,15 \text{ K}))]$		3411		K
B-value	$B_{25/100}$	$R_2 = R_{25} \exp[B_{25/100}(1/T_2 - 1/(298,15 \text{ K}))]$		3433		K

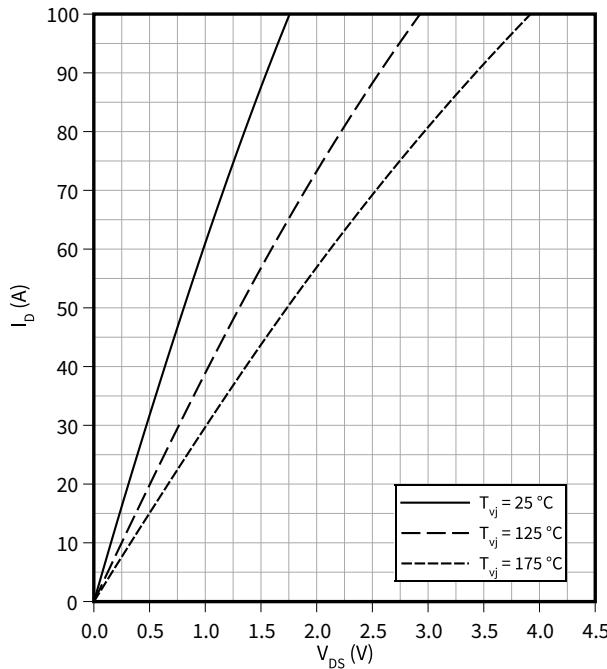
*Note:* Specification according to the valid application note.

## 8 Characteristics diagrams

### Output characteristic (typical), MOSFET

$I_D = f(V_{DS})$

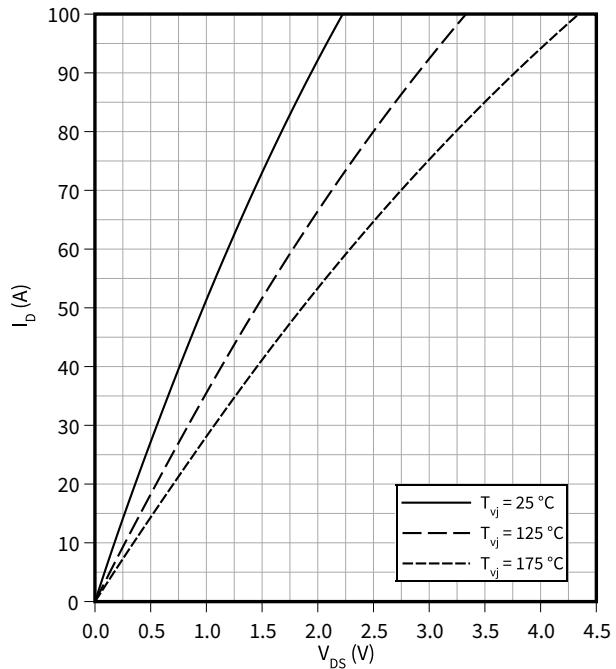
$V_{GS} = 18 \text{ V}$



### Output characteristic (typical), MOSFET

$I_D = f(V_{DS})$

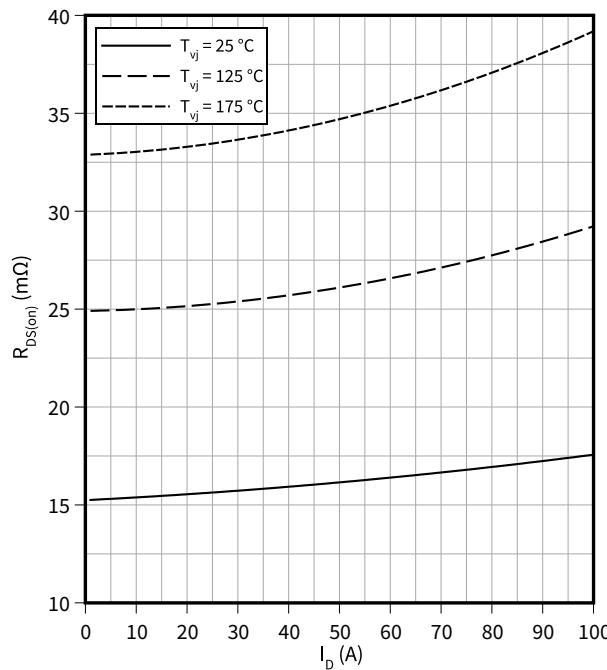
$V_{GS} = 15 \text{ V}$



### Drain source on-resistance (typical), MOSFET

$R_{DS(on)} = f(I_D)$

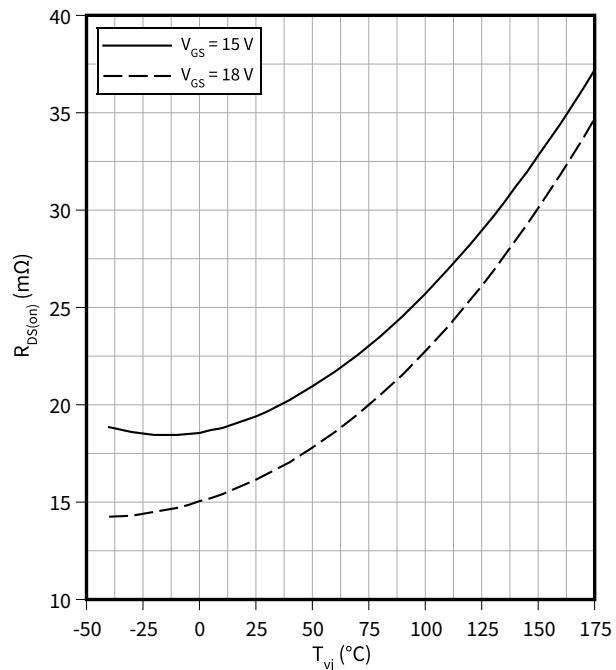
$V_{GS} = 18 \text{ V}$



### Drain source on-resistance (typical), MOSFET

$R_{DS(on)} = f(T_{vj})$

$I_D = 50 \text{ A}$

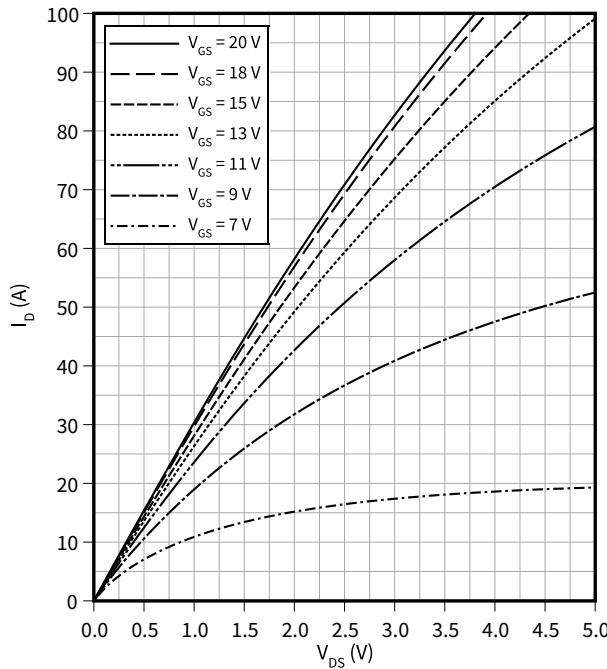


8 Characteristics diagrams

**Output characteristic field (typical), MOSFET**

$I_D = f(V_{DS})$

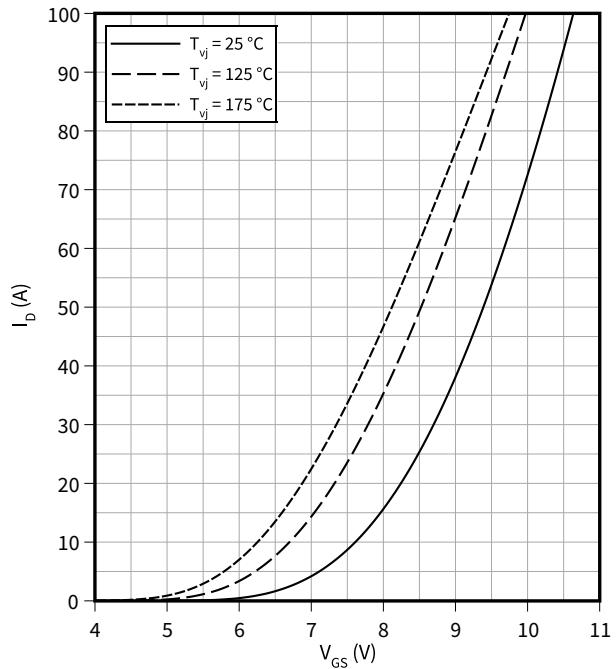
$T_{vj} = 175^\circ C$



**Transfer characteristic (typical), MOSFET**

$I_D = f(V_{GS})$

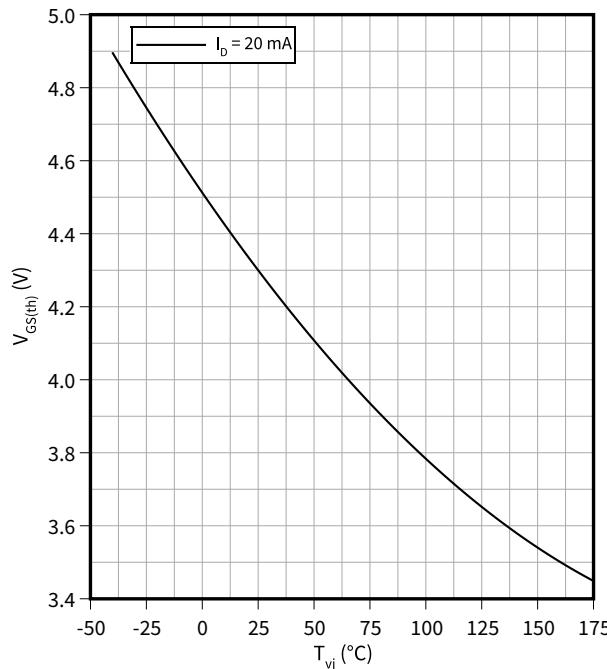
$V_{DS} = 20 V$



**Gate-source threshold voltage (typical), MOSFET**

$V_{GS(th)} = f(T_{vj})$

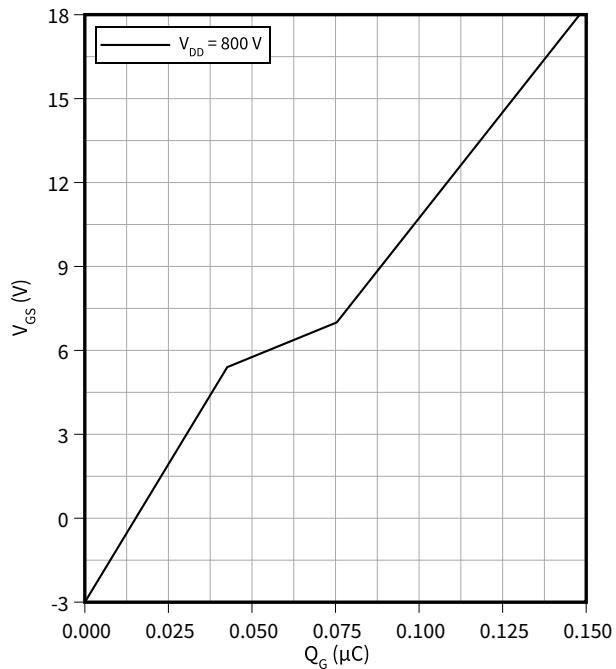
$V_{GS} = V_{DS}$



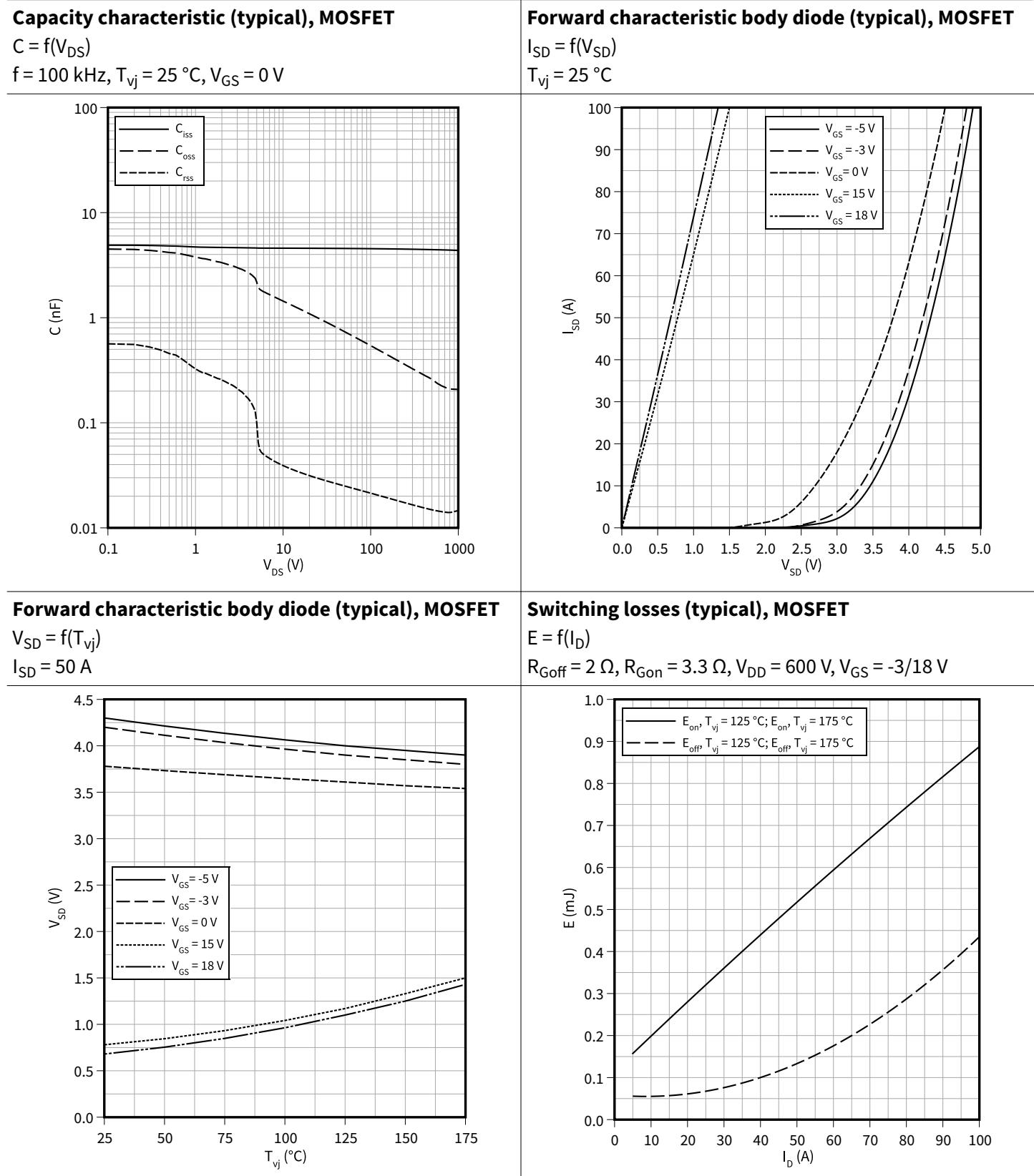
**Gate charge characteristic (typical), MOSFET**

$V_{GS} = f(Q_G)$

$I_D = 50 \text{ A}, T_{vj} = 25^\circ C$



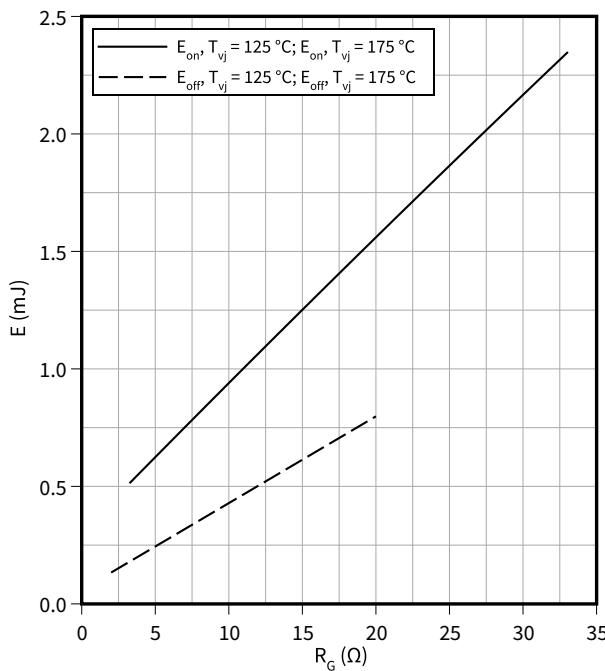
8 Characteristics diagrams



**Switching losses (typical), MOSFET**

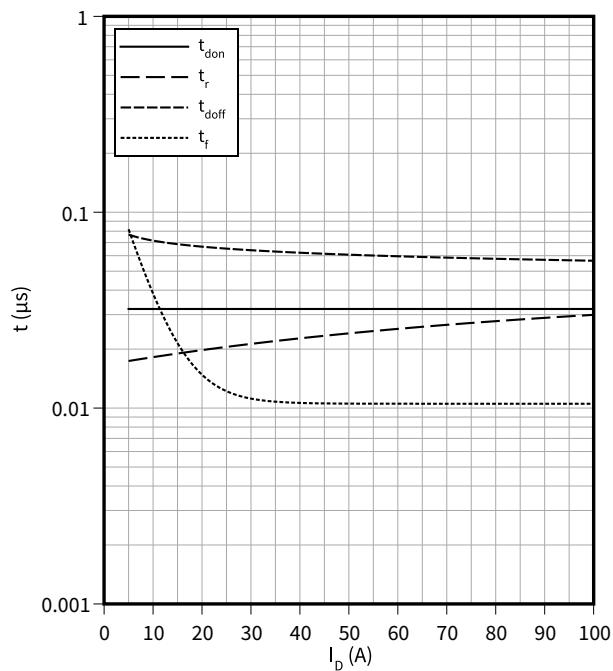
$$E = f(R_G)$$

$V_{DD} = 600 \text{ V}$ ,  $I_D = 50 \text{ A}$ ,  $V_{GS} = -3/18 \text{ V}$

**Switching times (typical), MOSFET**

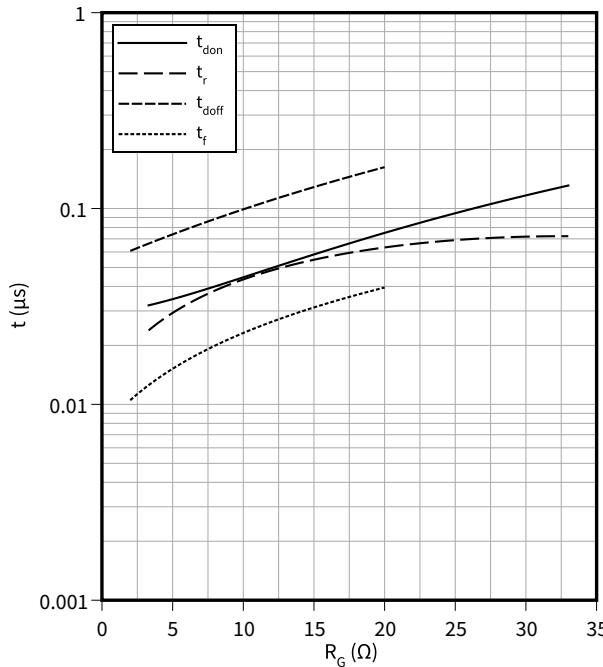
$$t = f(I_D)$$

$R_{Goff} = 2 \Omega$ ,  $R_{Gon} = 3.3 \Omega$ ,  $V_{DD} = 600 \text{ V}$ ,  $T_{vj} = 175 \text{ °C}$ ,  $V_{GS} = -3/18 \text{ V}$

**Switching times (typical), MOSFET**

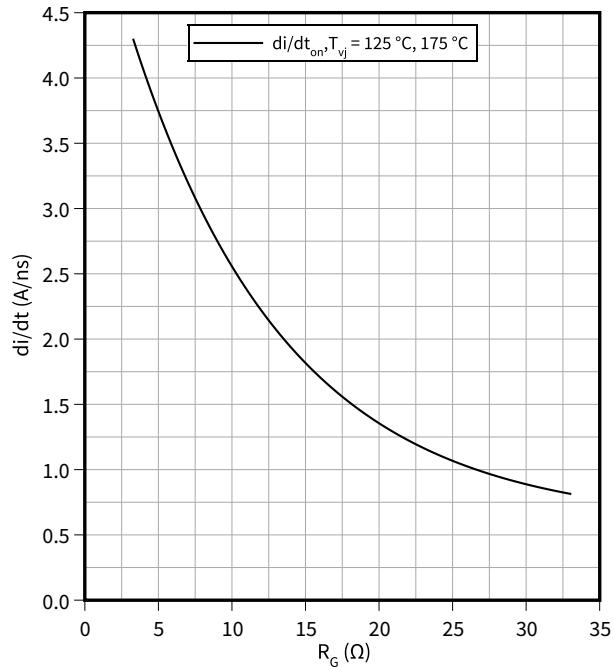
$$t = f(R_G)$$

$V_{DD} = 600 \text{ V}$ ,  $I_D = 50 \text{ A}$ ,  $T_{vj} = 175 \text{ °C}$ ,  $V_{GS} = -3/18 \text{ V}$

**Current slope (typical), MOSFET**

$$di/dt = f(R_G)$$

$V_{DD} = 600 \text{ V}$ ,  $I_D = 50 \text{ A}$ ,  $V_{GS} = -3/18 \text{ V}$

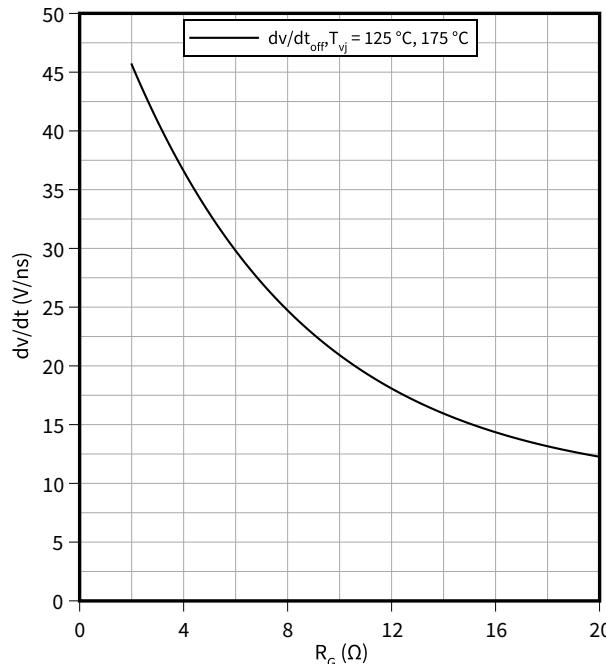


## 8 Characteristics diagrams

**Voltage slope (typical), MOSFET**

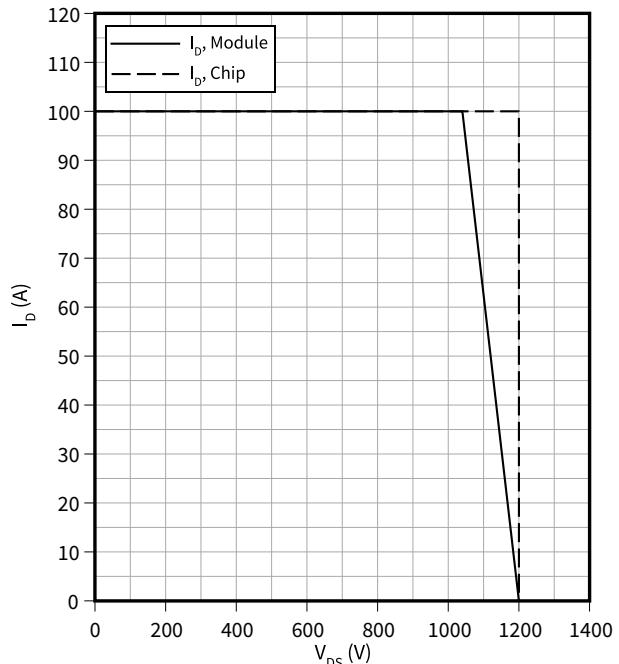
$$dv/dt = f(R_G)$$

$$V_{DD} = 600 \text{ V}, I_D = 50 \text{ A}, V_{GS} = -3/18 \text{ V}$$

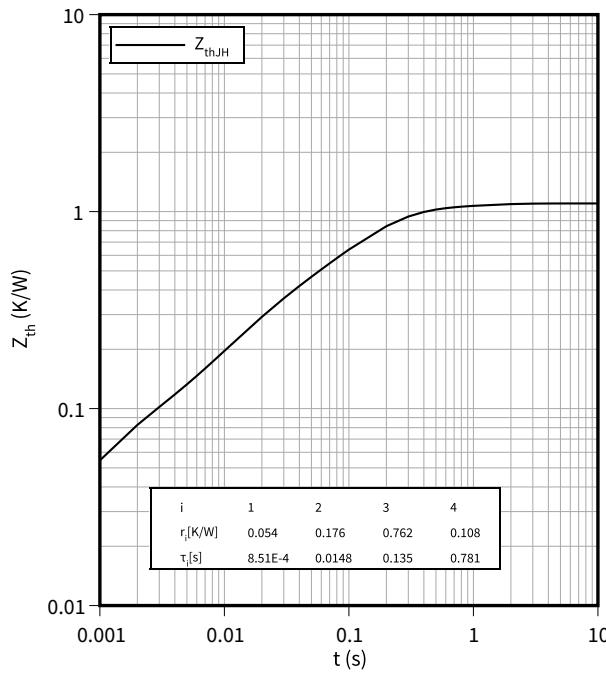
**Reverse bias safe operating area (RBSOA), MOSFET**

$$I_D = f(V_{DS})$$

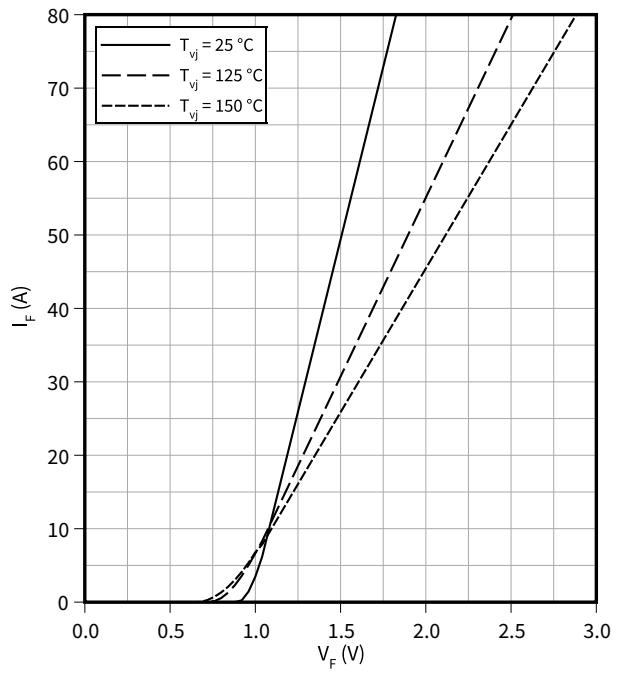
$$R_{Goff} = 2 \Omega, T_{vj} = 175^\circ\text{C}, V_{GS} = -3/18 \text{ V}$$

**Transient thermal impedance , MOSFET**

$$Z_{th} = f(t)$$

**Forward characteristic (typical), Diode, Boost**

$$I_F = f(V_F)$$

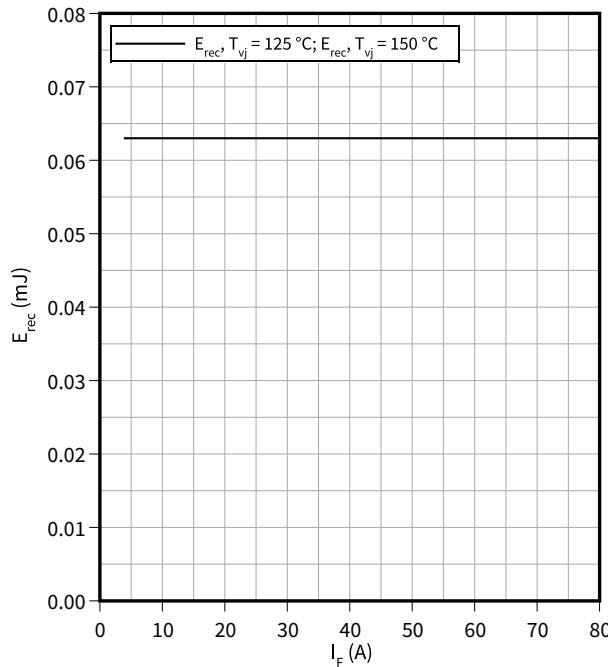


## 8 Characteristics diagrams

**Switching losses (typical), Diode, Boost**

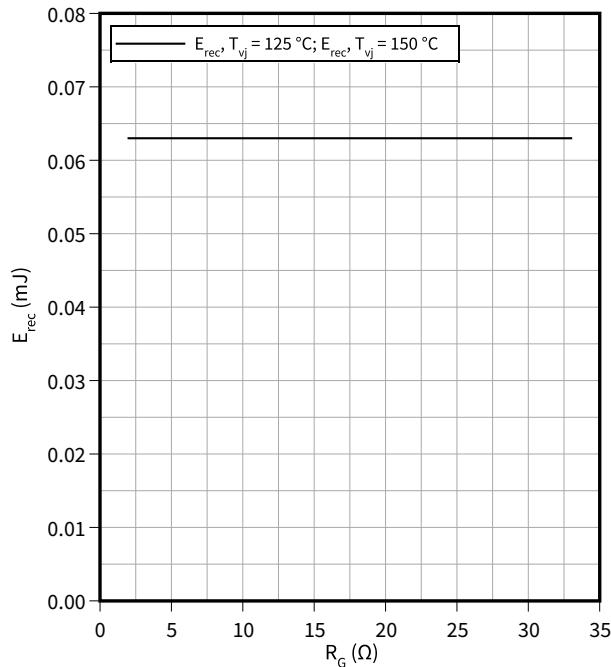
$$E_{rec} = f(I_F)$$

$$R_{Gon} = 3.3 \Omega, V_{CC} = 600 \text{ V}$$

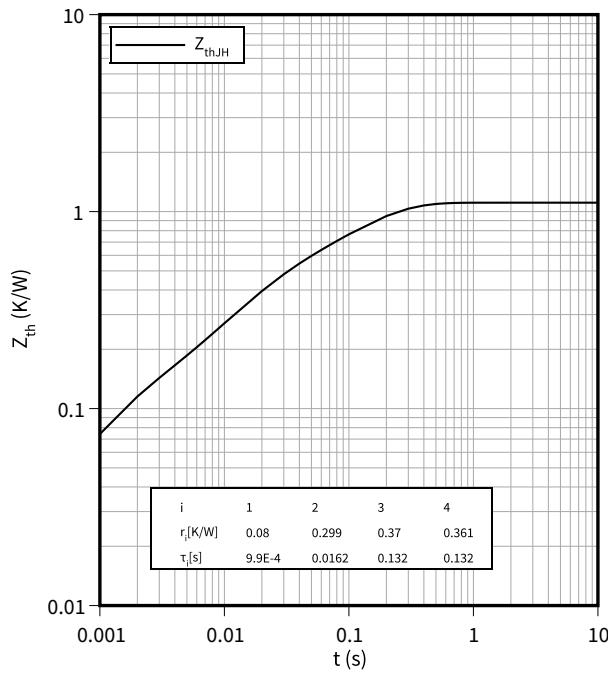
**Switching losses (typical), Diode, Boost**

$$E_{rec} = f(R_G)$$

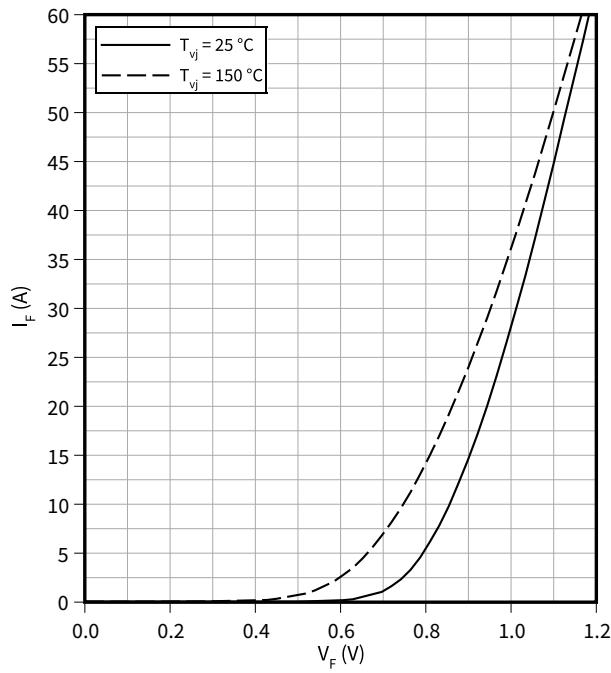
$$I_F = 40 \text{ A}, V_{CC} = 600 \text{ V}$$

**Transient thermal impedance, Diode, Boost**

$$Z_{th} = f(t)$$

**Forward characteristic (typical), Bypass-diode**

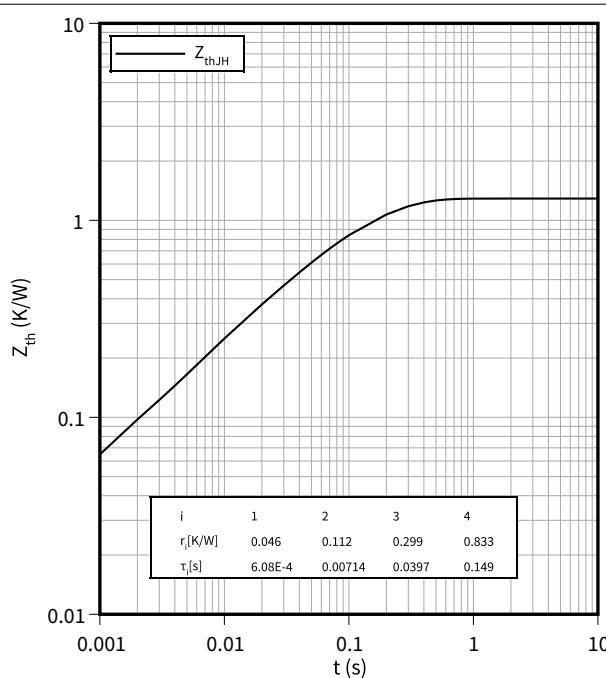
$$I_F = f(V_F)$$



8 Characteristics diagrams

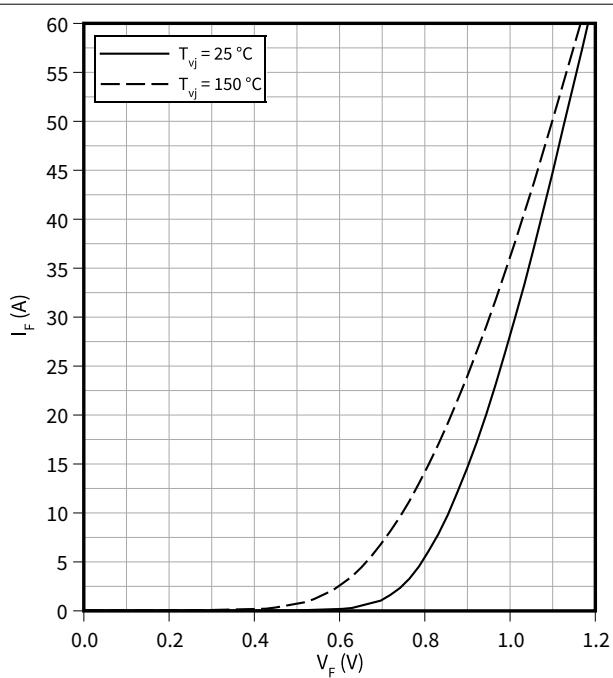
**Transient thermal impedance, Bypass-diode**

$$Z_{th} = f(t)$$



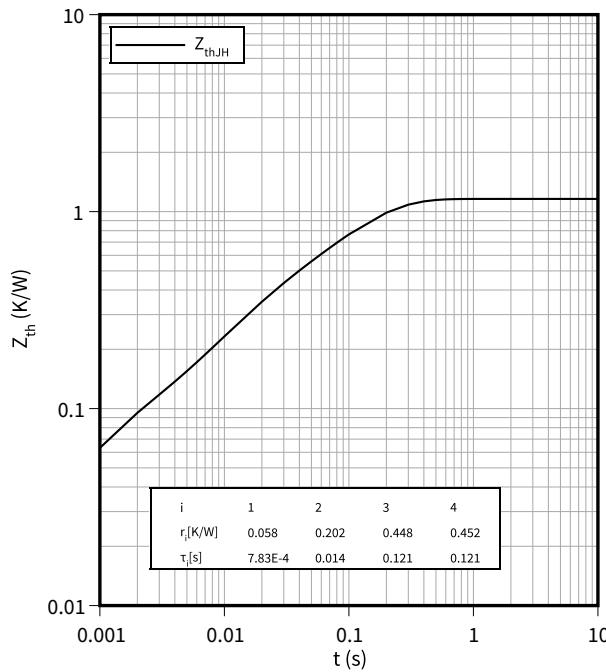
**Forward characteristic (typical), Inverse-polarity protection diode**

$$I_F = f(V_F)$$



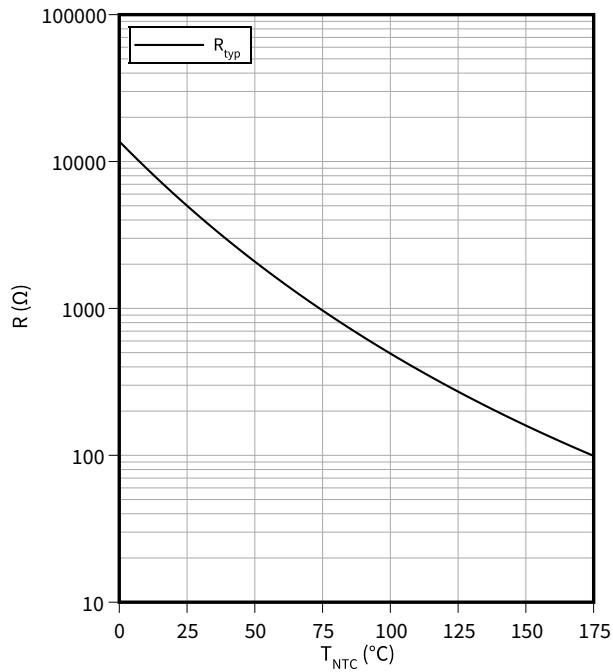
**Transient thermal impedance, Inverse-polarity protection diode**

$$Z_{th} = f(t)$$

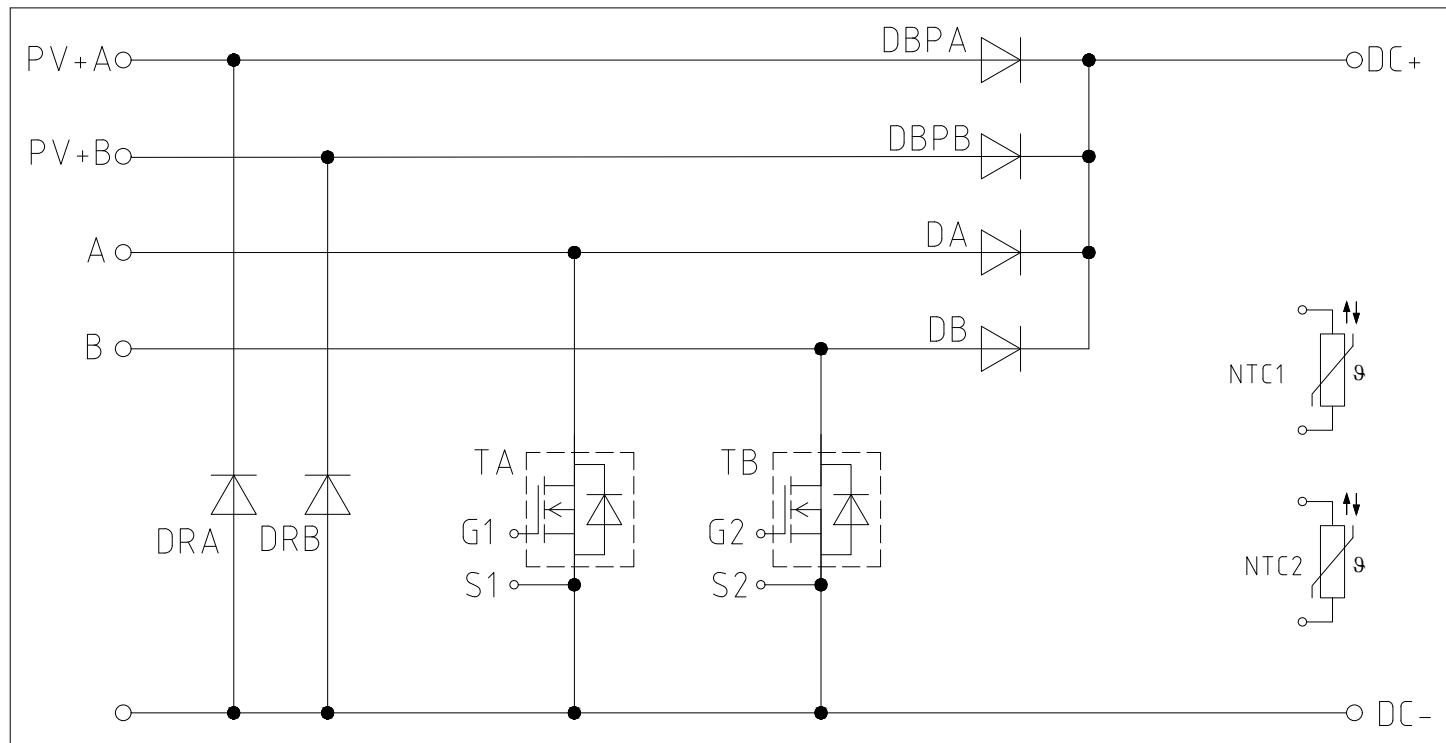


**Temperature characteristic (typical), NTC-Thermistor**

$$R = f(T_{NTC})$$



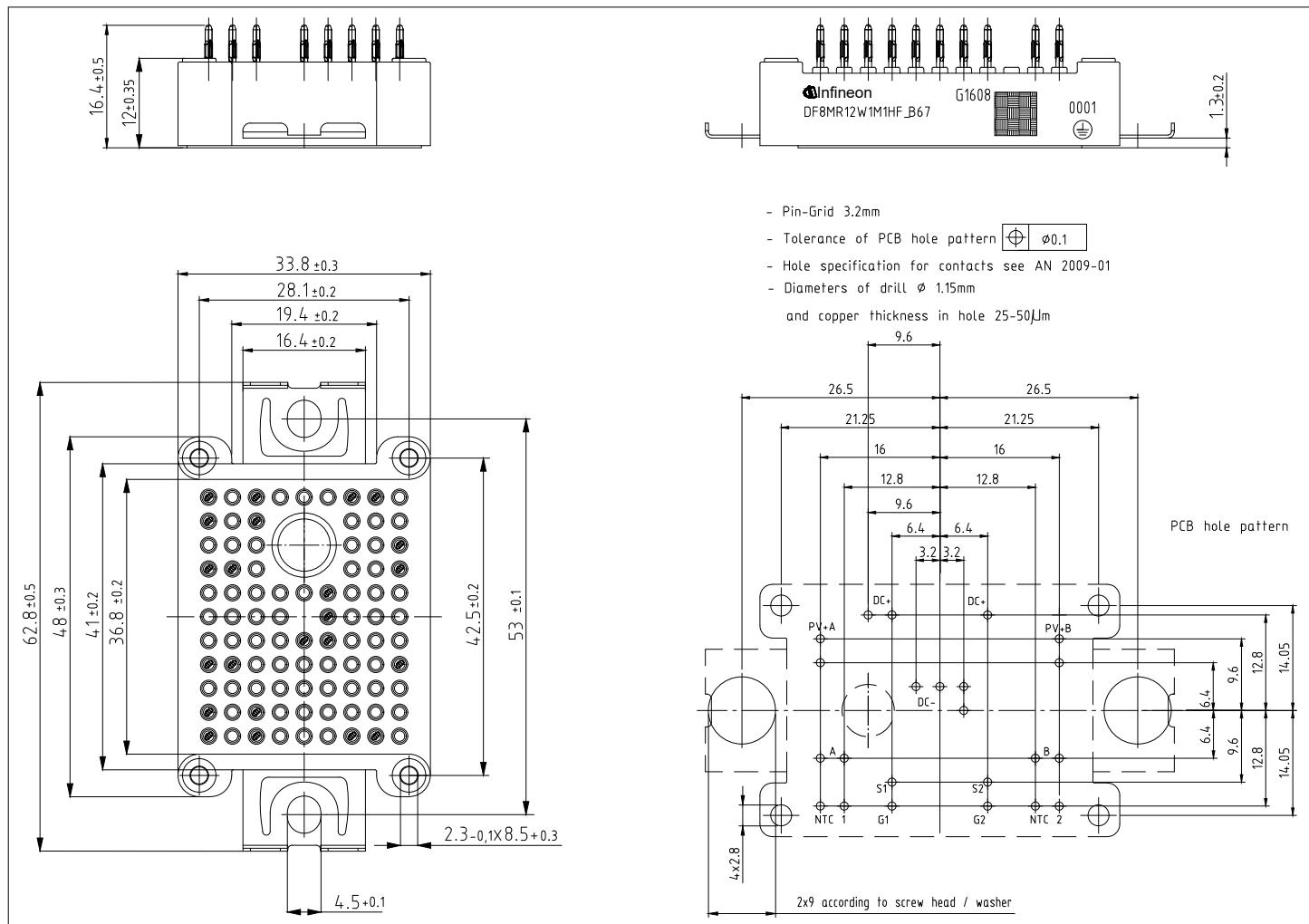
**9 Circuit diagram**



**Figure 1**

10 Package outlines

## 10 Package outlines



**Figure 2**

## 11 Module label code

## 11 Module label code

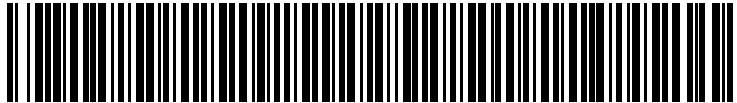
<b>Module label code</b>			
Code format	Data Matrix		Barcode Code128
Encoding	ASCII text		Code Set A
Symbol size	16x16		23 digits
Standard	IEC24720 and IEC16022		IEC8859-1
Code content	<p><i>Content</i></p> <p>Module serial number Module material number Production order number Date code (production year) Date code (production week)</p>	<p><i>Digit</i></p> <p>1 – 5 6 - 11 12 - 19 20 – 21 22 – 23</p>	<p><i>Example</i></p> <p>71549 142846 55054991 15 30</p>
Example			71549142846550549911530

Figure 3

## Revision history

<b>Document version</b>	<b>Date of release</b>	<b>Description of changes</b>
0.10	2022-11-21	Initial version